

ON Semiconductor®

FDMC6676PZ

P-Channel Power Trench® MOSFET General Description -30 V, -20 A, 14.4 mΩ

Features

- Max $r_{DS(on)}$ = 14.4 m Ω at V_{GS} = -10 V, I_D = -9.5 A
- Max $r_{DS(on)}$ = 27.0 m Ω at V_{GS} = -4.5 V, I_D = -6.9 A
- HBM ESD protection level of 8 kV typical(note 3)
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability

1 2 3 4

■ Termination is Lead-free and RoHS Compliant

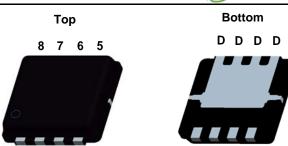


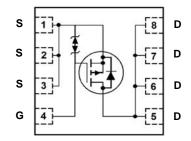
GSSS

The FDMC6676PZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest r_{DS(on)} and ESD protection.

Application

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management





MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			-30	V
V_{GS}	Gate to Source Voltage			±25	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		-20	
	-Continuous (Silicon limited)	T _C = 25 °C		-40	A
I _D	-Continuous	T _A = 25 °C	(Note 1a)	-9.5	
	-Pulsed			-32	
P _D	Power Dissipation	T _C = 25 °C		36	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.4	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction to Board (Note 1c)	7.4	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
WUCIN	FDMC6676PZ	MLP 3.3X3.3	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V},$ $V_{GS} = 0 \text{ V}$ $T_{J} = 125 \text{ °C}$			-1 -100	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1.0	-1.9	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		-6		mV/°C
		$V_{GS} = -10 \text{ V}, I_D = -9.5 \text{ A}$		10.7	14.4	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -6.9 \text{ A}$		17.4	27.0	mΩ
, ,		$V_{GS} = -10 \text{ V}, I_D = -9.5 \text{ A}, T_J = 125 \text{ °C}$		15.2	20.5	
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, \ I_D = -9.5 \text{ A}$		28		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	2154	2865	pF
C _{oss}	Output Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	392	525	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/2	349	525	pF

Switching Characteristics

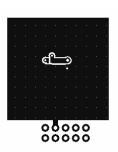
t _{d(on)}	Turn-On Delay Time				11	20	ns
t _r	Rise Time		V_{DD} = -15 V, I_{D} = -9.5 A, V_{GS} = -10 V, R_{GEN} = 6 Ω		10	20	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -10 \text{ V}, R_{GEN}$			44	71	ns
t _f	Fall Time				26	42	ns
0	Total Gate Charge	$V_{GS} = 0 \text{ V to -10 V}$	$V_{GS} = 0 \text{ V to -10 V}$ $V_{GS} = 0 \text{ V to -5 V}$ $V_{DD} = -15 \text{ V},$		46	65	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to -5 V}$			26	37	nC
Q_{gs}	Gate to Source Charge		$I_D = -9.5 \text{ A}$		6.4		nC
Q_{gd}	Gate to Drain "Miller" Charge				13		nC

Drain-Source Diode Characteristics

\/	Ved Source to Drain Diode Forward voltage	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -9.5 \text{ A}$ (Note 2)	0.89	1.3	V
Į v s		$V_{GS} = 0 \text{ V}, I_S = -1.6 \text{ A}$ (Note 2)	0.73	1.2	V	
t _{rr}		Reverse Recovery Time	I _F = -9.5 A, di/dt = 100 A/μs	24	38	ns
Q	rr	Reverse Recovery Charge	I _F = -9.5 A, α/αι = 100 A/μs	15	27	nC

NOTES

^{1.} R_{BJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper



c. 7.4 °C/W when mounted on PCB and tested per EIA/JEDEC

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.
- 3. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

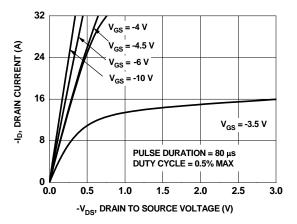


Figure 1. On Region Characteristics

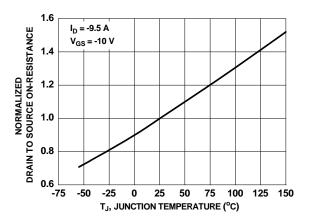


Figure 3. Normalized On Resistance vs Junction Temperature

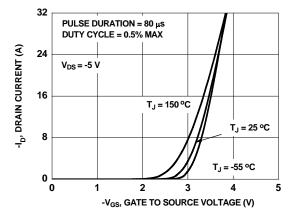


Figure 5. Transfer Characteristics

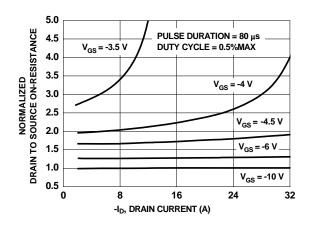


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

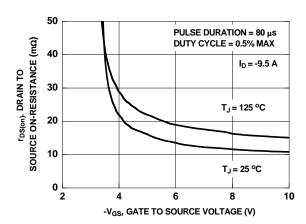


Figure 4. On-Resistance vs Gate to Source Voltage

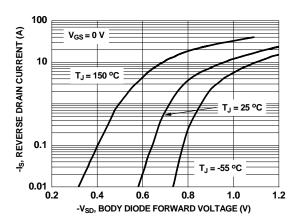


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

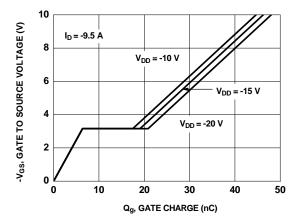


Figure 7. Gate Charge Characteristics

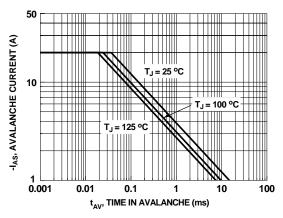


Figure 9. Unclamped Inductive Switching Capability

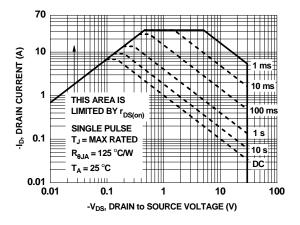


Figure 11. Forward Bias Safe Operating Area

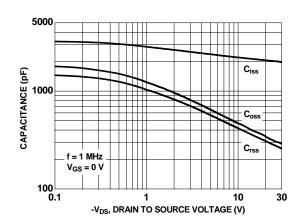


Figure 8. Capacitance vs Drain to Source Voltage

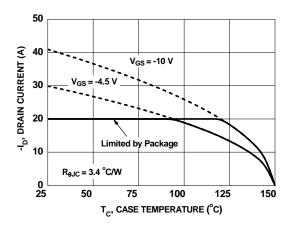


Figure 10. Maximum Continuous Drain Current vs Case Temperature

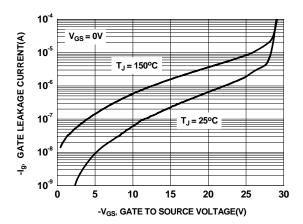


Figure 12. I_{qss} vs V_{qss}

Typical Characteristics T_J = 25 °C unless otherwise noted

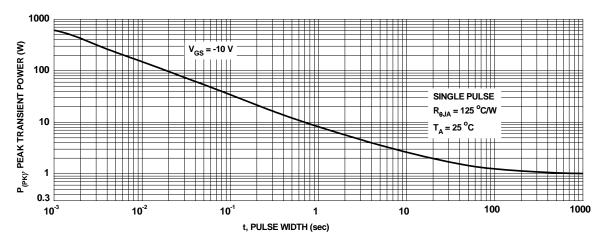


Figure 13. Single Pulse Maximum Power Dissipation

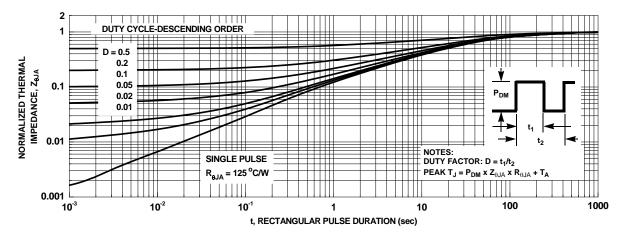
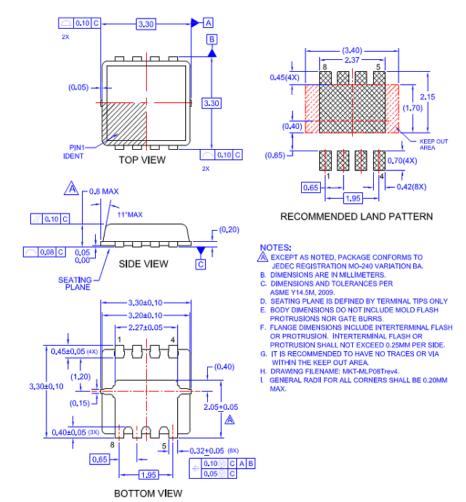


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout



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